

Notice of References Cited

Application/Control No.

09/585,460

Applicant(s)/Patent Under
Reexamination
STRIETZEL, JONATHAN

Examiner

Quynh H. Nguyen

Art Unit

2614

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,603,844	08-2003	Chavez et al.	379/114.13
	B	US-			
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	E	US-			
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	I	US-			
	J	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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